

# FOD2200

## Low Input Current Logic Gate Optocouplers

### Features

- 1kV/ $\mu$ s minimum common mode rejection
- Compatible with LSTTL, TTL, and CMOS logic
- Wide  $V_{CC}$  range (4.5V to 20V)
- 2.5Mbd guaranteed over temperature
- Low input current (1.6mA)
- Three state output (no pullup resistor required)
- Guaranteed performance from 0°C to 85°C
- Hysteresis
- Safety approvals pending – UL, CSA, VDE
- $V_{ISO} = 5kV_{RMS}$

### Applications

- Isolation of high speed logic systems
- Computer peripheral interfaces
- Microprocessor system interfaces
- Ground loop elimination
- Pulse transformer replacement
- Isolated bus driver
- High speed line receiver

### Description

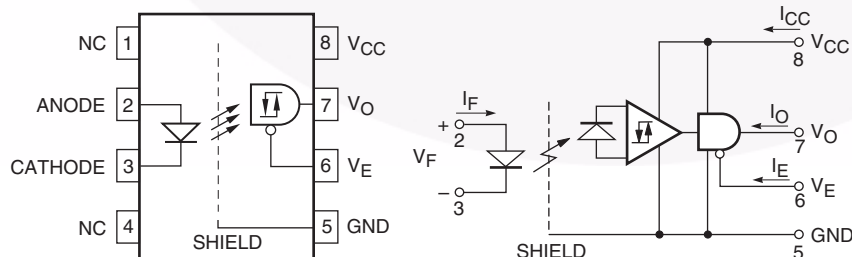
The FOD2200 is an optically coupled logic gate that combine an AlGaAs LED and an integrated high gain photo detector. The detector has a three state output stage and has a detector threshold with hysteresis. The three state output eliminates the need for a pullup resistor and allows for direct drive of data busses. The hysteresis provides differential mode noise immunity and eliminates the potential for output signal chatter.

The Electrical and Switching Characteristics of the FOD2200 are guaranteed over the temperature range of 0°C to 85°C and a  $V_{CC}$  range of 4.5V to 20V. Low  $I_F$  and wide  $V_{CC}$  range allow compatibility with TTL, LSTTL, and CMOS logic and result in lower power consumption compared to other high speed opto-couplers. Logic signals are transmitted with a maximum propagation delay of 300ns. The FOD2200 is useful for isolating high speed logic interfaces, buffering of input and output lines, and implementing isolated line receivers in high noise environments.

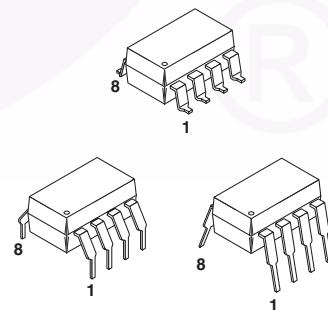
### Truth Table (Positive Logic)

LED	Enable	Output
On	H	Z
Off	H	Z
On	L	H
Off	L	L

### Functional Block Diagram and Schematic



### Package Outlines



**Absolute Maximum Ratings** ( $T_A = 25^\circ\text{C}$  unless otherwise specified)

Stresses exceeding the absolute maximum ratings may damage the device. The device may not function or be operable above the recommended operating conditions and stressing the parts to these levels is not recommended. In addition, extended exposure to stresses above the recommended operating conditions may affect device reliability. The absolute maximum ratings are stress ratings only.

Symbol	Parameter	Value	Units
$T_{STG}$	Storage Temperature	-40 to +125	$^\circ\text{C}$
$T_{OPR}$	Operating Temperature	-40 to +85	$^\circ\text{C}$
$T_{SOL}$	Lead Solder Temperature (1.6mm below seating plane)	260 for 10 sec	$^\circ\text{C}$
<b>EMITTER</b>			
$I_F(PK)$	Peak Transient Input Current ( $\leq 1\mu\text{s}$ PW, 300pps)	1.0	A
$I_F$	Average Forward Input Current	10	mA
$V_R$	Reverse Input voltage	5.0	V
$P_D$	Output Power Dissipation (No derating required up to $85^\circ\text{C}$ )	45	mW
<b>DETECTOR</b>			
$V_{CC}$	Supply Voltage	0 to 20	V
$I_O$	Average Output Current	25	mA
$V_E$	Three State Enable Voltage	-0.5 to 20	V
$V_O$	Output Voltage	-0.5 to 20	V
$P_D$	Output Power Dissipation (No derating required up to $85^\circ\text{C}$ )	150	mW

**Recommended Operating Conditions**

The Recommended Operating Conditions table defines the conditions for actual device operation. Recommended operating conditions are specified to ensure optimal performance to the datasheet specifications. Fairchild does not recommend exceeding them or designing to absolute maximum ratings.

Symbol	Parameter	Min.	Max.	Units
$I_{F(ON)}$	Forward Input Current	1.6*	5	mA
$I_{F(OFF)}$	Forward Input Current		0.1	mA
$V_{CC}$	Supply Voltage, Output	4.5	20	V
$V_{EL}$	Enable Voltage, LOW Level	0	0.8	V
$V_{EH}$	Enable Voltage, HIGH Level	2.0	20	V
$T_A$	Operating Temperature	0	+85	$^\circ\text{C}$
N	Fan Out (TTL Load)		4	

\*The initial switching threshold is 1.6mA or less. It is recommended that 2.2mA be used to permit at least a 20% CTR degradation guardband.

**Electrical Characteristics** ( $T_A = 0^\circ\text{C}$  to  $+85^\circ\text{C}$ ,  $V_{CC} = 4.5\text{V}$  to  $20\text{V}$ ,  $I_{F(ON)} = 1.6\text{mA}$  to  $5\text{mA}$ ,  $V_{EH} = 2\text{V}$  to  $20\text{V}$ ,  $V_{EL} = 0\text{V}$  to  $0.8\text{V}$ ,  $I_{F(OFF)} = 0\text{mA}$  to  $0.1\text{mA}$  unless otherwise specified.)<sup>(1)</sup>

**Individual Component Characteristics**

Symbol	Parameter	Test Conditions	Min.	Typ.*	Max.	Unit
<b>EMITTER</b>						
$V_F$	Input Forward Voltage	$I_F = 5\text{mA}$			1.75	V
			$T_A = 25^\circ\text{C}$		1.40	1.7
$B_{VR}$	Input Reverse Breakdown Voltage	$I_R = 10\mu\text{A}$	5.0			V
$C_{IN}$	Input Capacitance	Pins 2 & 3, $V_F = 0$ , $f = 1\text{MHz}$		60		pF
$\Delta V_F/\Delta T_A$	Input Diode Temperature Coefficient	$I_F = 5\text{mA}$		-1.4		mV/ $^\circ\text{C}$
<b>DETECTOR</b>						
$I_{CCH}$	High Level Supply Current	$I_F = 5\text{mA}$ , $I_O = \text{Open}$ , $V_E = \text{Don't Care}$	$V_{CC} = 5.5\text{V}$	3.5	4.5	mA
			$V_{CC} = 20\text{V}$	4.0	6.0	
$I_{CCL}$	Low Level Supply Current	$I_F = 0$ , $I_O = \text{Open}$ , $V_E = \text{Don't care}$	$V_{CC} = 5.5\text{V}$	4.4	6.0	mA
			$V_{CC} = 20\text{V}$	5.2	7.5	
$I_{EL}$	Low Level Enable Current	$V_E = 0.4\text{V}$		-0.1	-0.32	mA
$I_{EH}$	High Level Enable Current	$V_E = 2.7\text{V}$			20	$\mu\text{A}$
		$V_E = 5.5\text{V}$			100	
		$V_E = 20\text{V}$		0.005	250	
$V_{EH}$	High Level Enable Voltage		2.0			V
$V_{EL}$	Low Level Enable Voltage				0.8	V

**Switching Characteristics** ( $T_A = 0^\circ\text{C}$  to  $+85^\circ\text{C}$ ,  $I_{F(ON)} = 1.6\text{mA}$  to  $5\text{mA}$ ,  $I_{F(OFF)} = 0$  to  $0.1\text{mA}$ ,  $V_{CC} = 4.5\text{V}$  to  $20\text{V}$  unless otherwise specified.)

Symbol	AC Characteristics	Test Conditions	Min.	Typ.*	Max.	Unit
$T_{PLH}$	Propagation Delay Time to Output High Level	With Peaking Capacitor <sup>(2)(4)</sup> (Fig. 1)		120	300	ns
$T_{PHL}$	Propagation Delay Time to Output Low Level	With Peaking Capacitor <sup>(3)(4)</sup> (Fig. 1)		180	300	ns
$t_r$	Output Rise Time (10% to 90%)	<sup>(5)</sup> (Fig. 1)		80		ns
$t_f$	Output Fall Time (90% to 10%)	<sup>(6)</sup> (Fig. 1)		25		ns
$t_{PZH}$	Enable Propagation Delay Time to Output High Level	(Fig. 2)		40		ns
$t_{PZL}$	Enable Propagation Delay Time to Output Low Level	(Fig. 2)		50		ns
$T_{PHZ}$	Disable Propagation Delay Time from Output High Level	(Fig. 2)		95		ns
$T_{PLZ}$	Disable Propagation Delay Time from Output Low Level	(Fig. 2)		80		ns
$ICM_{HI}$	Common Mode Transient Immunity (at Output High Level)	$T_A = 25^\circ\text{C}$ , $I_F = 1.6\text{mA}$ , $V_{OH} (\text{Min.}) = 2.0\text{V}$ , $V_{CC} = 5\text{V}^{(7)}$ (Fig. 3)	$ V_{CM}  = 50\text{V}$	1000		V/ $\mu\text{s}$
$ICM_{LI}$	Common Mode Transient Immunity (at Output Low Level)	$T_A = 25^\circ\text{C}$ , $I_F = 0\text{mA}$ , $V_{OL} (\text{Max.}) = 0.8\text{V}$ , $V_{CC} = 5\text{V}^{(8)}$ (Fig. 3)	$ V_{CM}  = 50\text{V}$	1000		V/ $\mu\text{s}$

\*Typical values at  $T_A = 25^\circ\text{C}$ ,  $V_{CC} = 5\text{V}$ ,  $I_{F(ON)} = 3\text{mA}$  unless otherwise specified.

**Electrical Characteristics** (Continued)

**Transfer Characteristics** ( $T_A = 0^\circ\text{C}$  to  $+85^\circ\text{C}$ ,  $V_{CC} = 4.5\text{V}$  to  $20\text{V}$ ,  $I_{F(\text{ON})} = 1.6\text{mA}$  to  $5\text{mA}$ ,  $V_{EH} = 2\text{V}$  to  $20\text{V}$ ,  $V_{EL} = 0\text{V}$  to  $0.8\text{V}$ ,  $I_{F(\text{OFF})} = 0\text{mA}$  to  $0.1\text{mA}$  unless otherwise specified.)<sup>(1)</sup>

Symbol	DC Characteristics	Test Conditions	Min.	Typ.*	Max.	Unit
$I_{\text{OHH}}$	Output Leakage Current ( $V_{\text{OUT}} > V_{\text{CC}}$ )	$V_{\text{CC}} = 4.5\text{V}$ , $I_{\text{F}} = 5\text{mA}$		2.0	100	$\mu\text{A}$
		$V_{\text{O}} = 5.5\text{V}$		2.5	500	
$V_{\text{OL}}$	Low Level Output Voltage	$V_{\text{CC}} = 4.5\text{V}$ , $I_{\text{F}} = 0\text{mA}$ , $V_{\text{E}} = 0.4\text{V}$ , $I_{\text{OL}} = 6.4\text{mA}$ <sup>(2)</sup>		0.33	0.5	V
$I_{\text{FT}}$	Input Threshold Current	$V_{\text{CC}} = 4.5\text{V}$ , $V_{\text{O}} = 0.5\text{V}$ , $V_{\text{E}} = 0.4\text{V}$ , $I_{\text{OL}} = 6.4\text{mA}$			1.6	mA
$V_{\text{OH}}$	Logic High Output Voltage	$I_{\text{OH}} = -2.6\text{mA}$	2.4	$V_{\text{CC}} - 1.8$		V
$I_{\text{OZL}}$	High Impedance State Output Current	$V_{\text{O}} = 0.4\text{V}$ , $V_{\text{EN}} = 2\text{V}$ , $I_{\text{F}} = 5\text{mA}$			-20	$\mu\text{A}$
$I_{\text{OZH}}$	High Impedance State Output Current	$V_{\text{O}} = 2.4\text{V}$ , $V_{\text{EN}} = 2\text{V}$ , $I_{\text{F}} = 5\text{mA}$			20	$\mu\text{A}$
		$V_{\text{O}} = 5.5\text{V}$ , $V_{\text{EN}} = 2\text{V}$ , $I_{\text{F}} = 5\text{mA}$			100	
		$V_{\text{O}} = 20\text{V}$ , $V_{\text{EN}} = 2\text{V}$ , $I_{\text{F}} = 5\text{mA}$			500	
$I_{\text{OSL}}$	Logic Low Short Circuit Output Current <sup>(10)</sup>	$V_{\text{O}} = V_{\text{CC}} = 5.5\text{V}$ , $I_{\text{F}} = 0\text{mA}$	25			mA
		$V_{\text{O}} = V_{\text{CC}} = 20\text{V}$ , $I_{\text{F}} = 0\text{mA}$	40			
$I_{\text{OSH}}$	Logic High Short Circuit Output Current <sup>(10)</sup>	$V_{\text{CC}} = 5.5\text{V}$ , $I_{\text{F}} = 5\text{mA}$ , $V_{\text{O}} = \text{GND}$	-10			mA
		$V_{\text{CC}} = 20\text{V}$ , $I_{\text{F}} = 5\text{mA}$ , $V_{\text{O}} = \text{GND}$	-25			
$I_{\text{HYS}}$	Input Current Hysteresis	$V_{\text{CC}} = 4.5\text{V}$		0.03		mA

**Isolation Characteristics** ( $T_A = 0^\circ\text{C}$  to  $+85^\circ\text{C}$  unless otherwise specified)

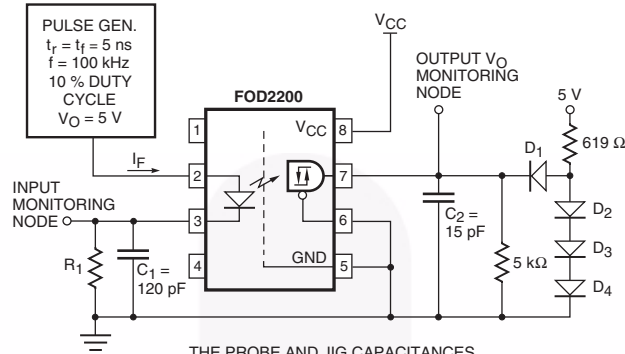
Symbol	Characteristics	Test Conditions	Min.	Typ.*	Max.	Unit
$V_{\text{ISO}}$	Withstand Insulation Test Voltage	$R_{\text{H}} < 50\%$ , $T_A = 25^\circ\text{C}$ , $t = 1\text{min.}$ <sup>(9)</sup>	5000			$V_{\text{RMS}}$
$R_{\text{I-O}}$	Resistance (Input to Output)	$V_{\text{I-O}} = 500\text{VDC}$ <sup>(9)</sup>		$10^{12}$		$\Omega$
$C_{\text{I-O}}$	Capacitance (Input to Output)	$V_{\text{I-O}} = 0\text{V}$ , $f = 1\text{MHz}$ <sup>(9)</sup>		0.6		pF

\*Typical values at  $T_A = 25^\circ\text{C}$ ,  $V_{\text{CC}} = 5\text{V}$ ,  $I_{\text{F}(\text{ON})} = 3\text{mA}$  unless otherwise stated.

**Notes:**

- The  $V_{\text{CC}}$  supply to each optoisolator must be bypassed by a  $0.1\mu\text{F}$  capacitor or larger. This can be either a ceramic or solid tantalum capacitor with good high frequency characteristic and should be connected as close as possible to the package  $V_{\text{CC}}$  and GND pins of each device.
- $t_{\text{PLH}}$  – Propagation delay is measured from the 50% level on the LOW to HIGH transition of the input current pulse to the 1.3V level on the LOW to HIGH transition of the output voltage pulse.
- $t_{\text{PHL}}$  – Propagation delay is measured from the 50% level on the HIGH to LOW transition of the input current pulse to the 1.3V level on the HIGH to LOW transition of the output voltage pulse.
- When the peaking capacitor is omitted, propagation delay times may increase by 100ns.
- $t_r$  – Rise time is measured from the 10% to the 90% levels on the LOW to HIGH transition of the output pulse.
- $t_f$  – Fall time is measured from the 90% to the 10% levels on the HIGH to LOW transition of the output pulse.
- $\text{CM}_{\text{H}}$  – The maximum tolerable rate of fall of the common mode voltage to ensure the output will remain in the high state (i.e.,  $V_{\text{OUT}} > 2.0\text{V}$ ).
- $\text{CM}_{\text{L}}$  – The maximum tolerable rate of rise of the common mode voltage to ensure the output will remain in the low state (i.e.,  $V_{\text{OUT}} < 0.8\text{V}$ ).
- Device considered a two-terminal device: Pins 1, 2, 3 and 4 shorted together, and Pins 5, 6, 7 and 8 shorted together.
- Duration of output short circuit time should not exceed 10ms.

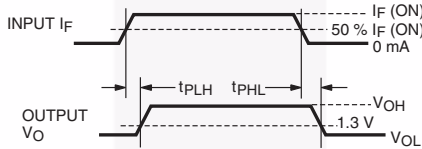
## Test Circuits



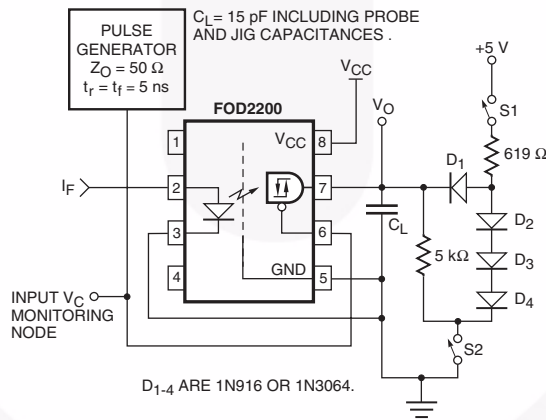
THE PROBE AND JIG CAPACITANCES ARE INCLUDED IN C<sub>1</sub> AND C<sub>2</sub>.

R <sub>1</sub>	2.15 kΩ	1.10 kΩ	681 Ω
I <sub>F</sub> (ON)	1.6 mA	3 mA	5 mA

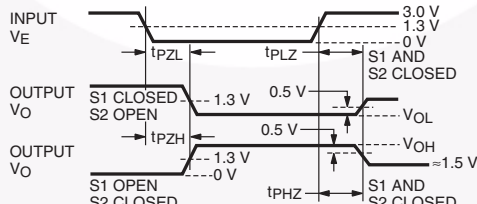
ALL DIODES ARE 1N916 OR 1N3064.



**Fig. 1. Test Circuit and Waveforms for t<sub>PLH</sub>, t<sub>PHL</sub>, t<sub>r</sub> and t<sub>f</sub>**

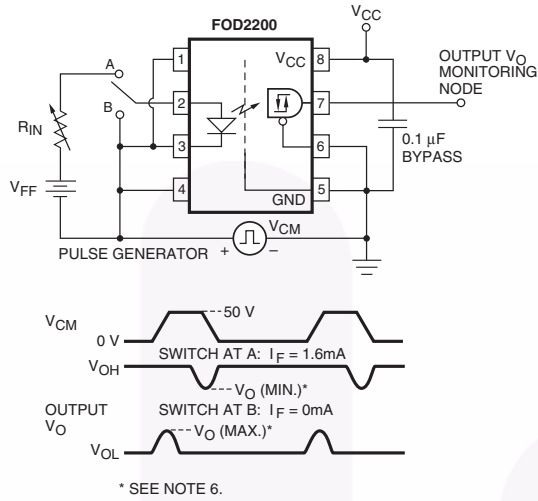


D<sub>1-4</sub> ARE 1N916 OR 1N3064.

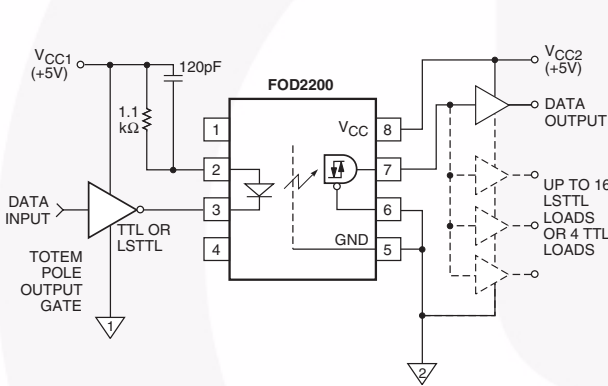


**Fig. 2. Test Circuit and Waveforms for t<sub>PHZ</sub>, t<sub>PZH</sub>, t<sub>PLZ</sub>, and t<sub>PZL</sub>**

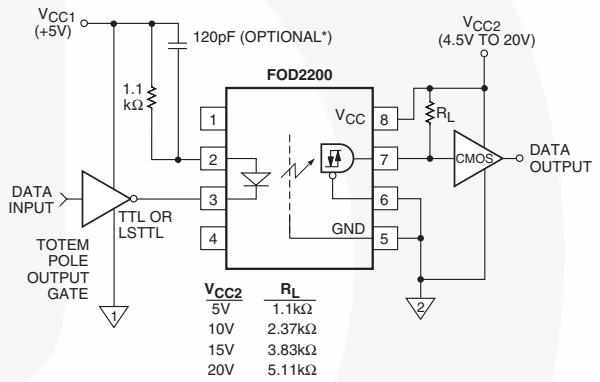
**Test Circuits** (Continued)



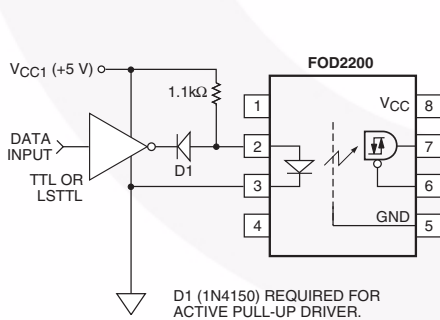
**Fig. 3. Test Circuit and Typical Waveforms for Common Mode Transient Immunity**



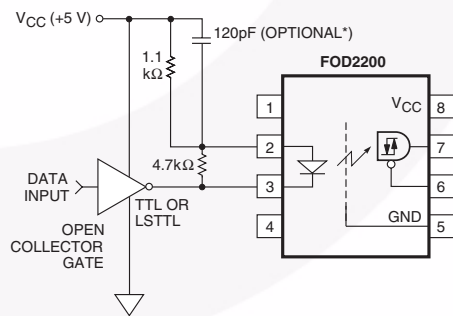
**Figure 4. Recommended LSTTL to LSTTL Circuit**



**Figure 5. LSTTL to CMOS Interface Circuit**



**Figure 6. Recommended LED Drive Circuit**

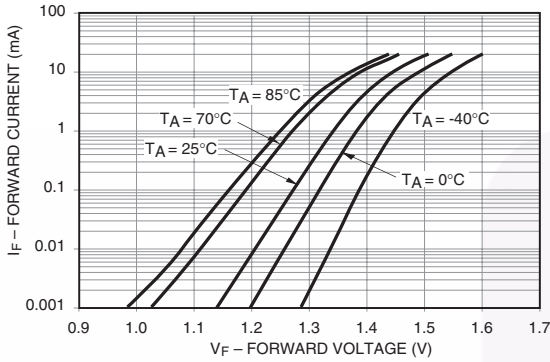


**Figure 7. Series LED Drive with Open Collector Gate (4.7kΩ Resistor Shunts I<sub>OH</sub> from the LED)**

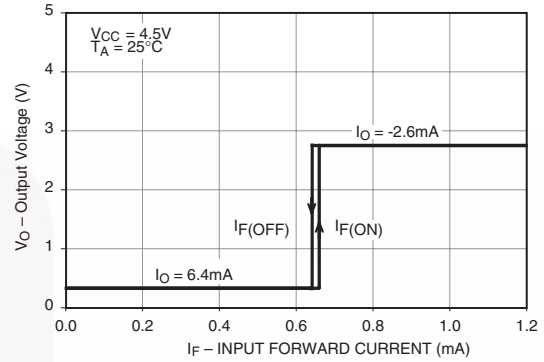
\*The 120pF capacitor may be omitted in applications where 500ns propagation delay is sufficient.

## Typical Performance Curves

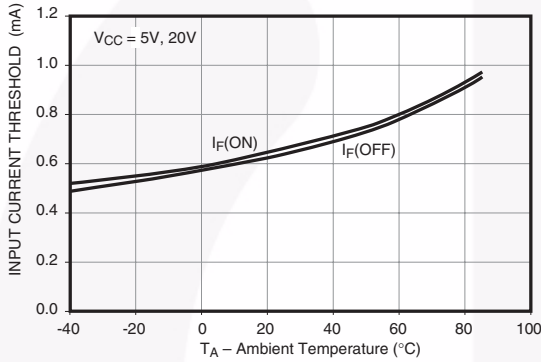
**Figure 8. Input Forward Current vs Forward Voltage**



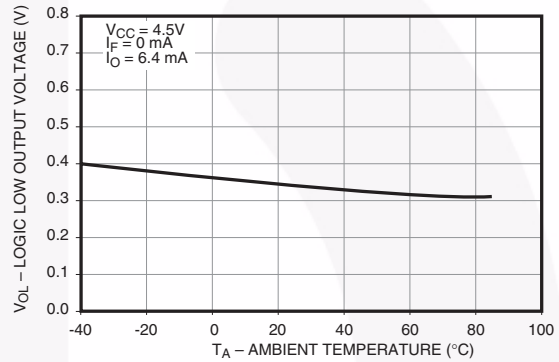
**Figure 9. Output Voltage vs. Input Forward Current**



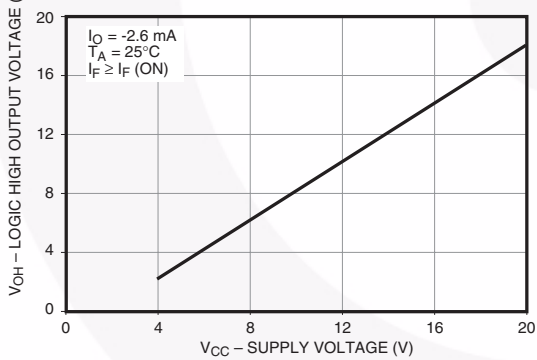
**Figure 10. Input Threshold Current vs. Ambient Temperature**



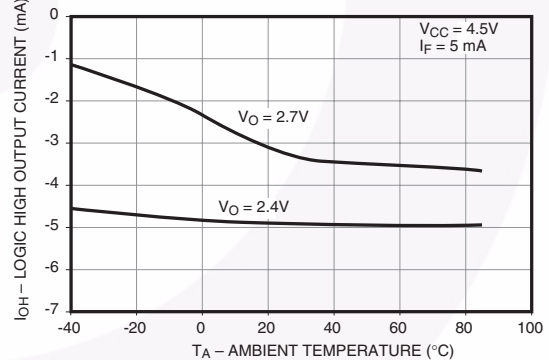
**Figure 11. Logic Low Output Voltage vs. Ambient Temperature**



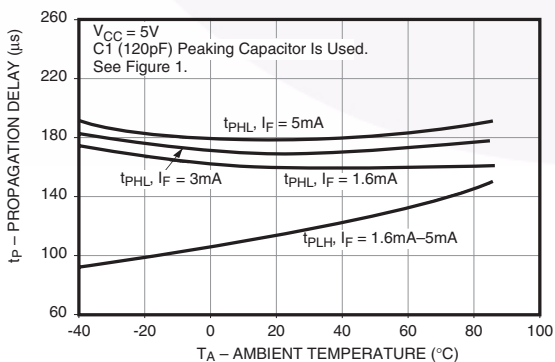
**Figure 12. Logic High Output Voltage vs. Supply Voltage**



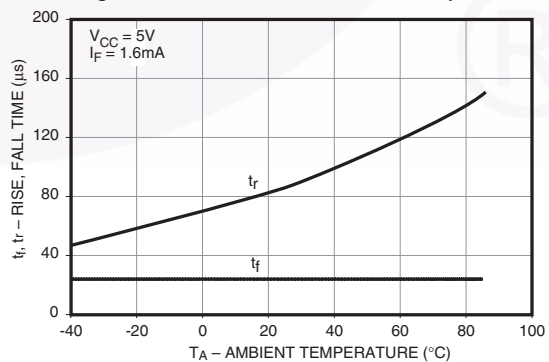
**Figure 13. Logic High Output Current vs. Ambient Temperature**



**Figure 14. Propagation Delay vs Ambient Temperature**

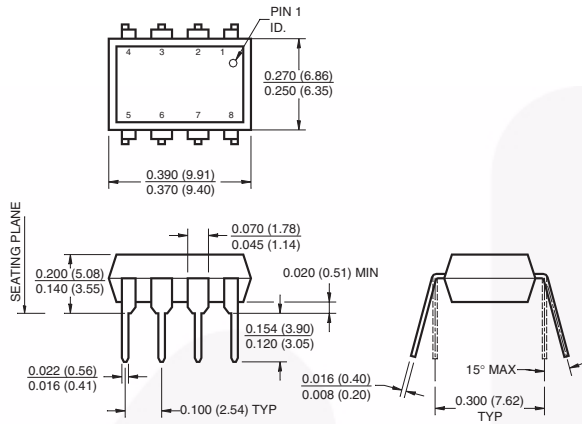


**Figure 15. Rise, Fall Time vs Ambient Temperature**

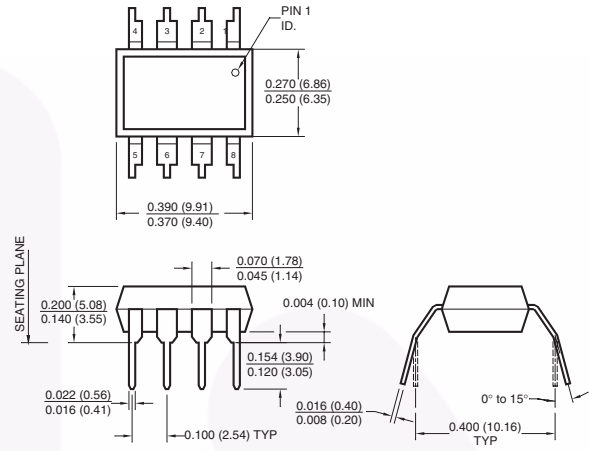


## Package Dimensions

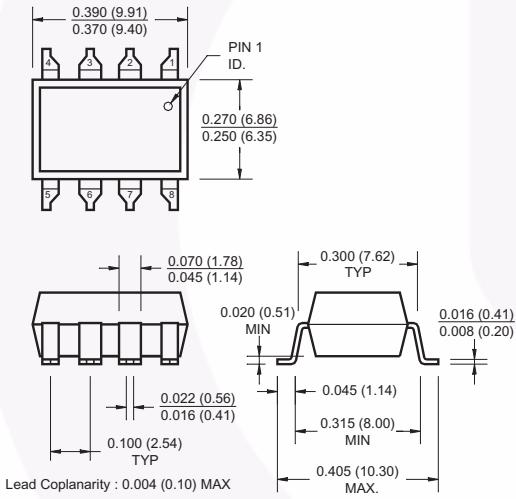
### Through Hole



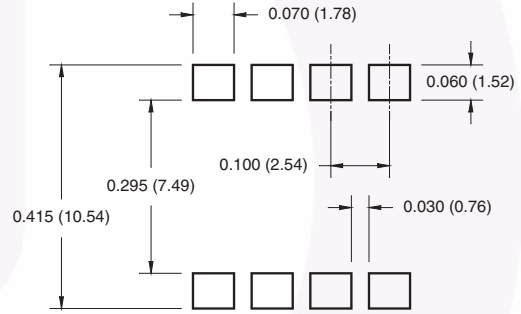
### 0.4" Lead Spacing



### Surface Mount



### 8-Pin DIP – Land Pattern



**Note:**

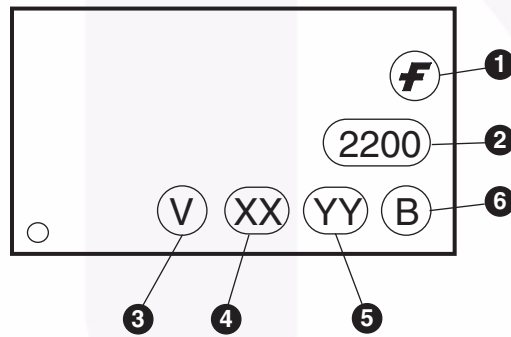
All dimensions are in inches (millimeters)



### Ordering Information

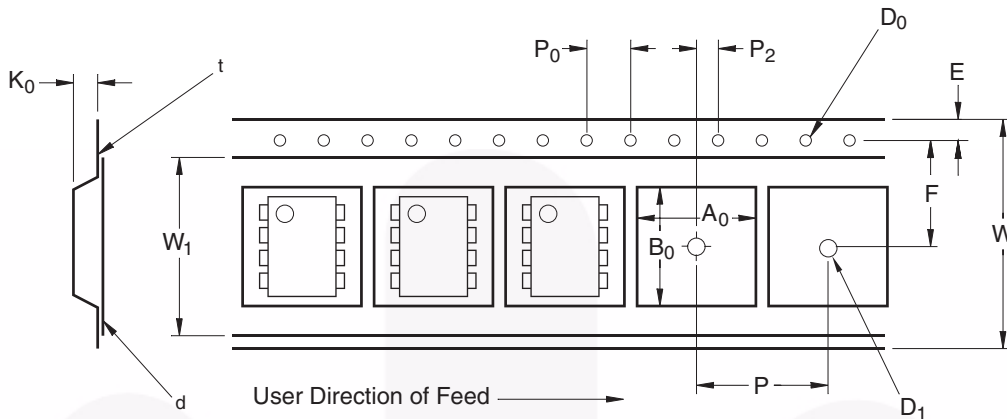
Option	Example Part Number	Description
No Option	FOD2200	Standard Through Hole
S	FOD2200S	Surface Mount Lead Bend
SD	FOD2200SD	Surface Mount; Tape and Reel
T	FOD2200T	0.4" Lead Spacing
V	FOD2200V	VDE0884
TV	FOD2200TV	VDE0884; 0.4" Lead Spacing
SV	FOD2200SV	VDE0884; Surface Mount
SDV	FOD2200SDV	VDE0884; Surface Mount; Tape and Reel

### Marking Information



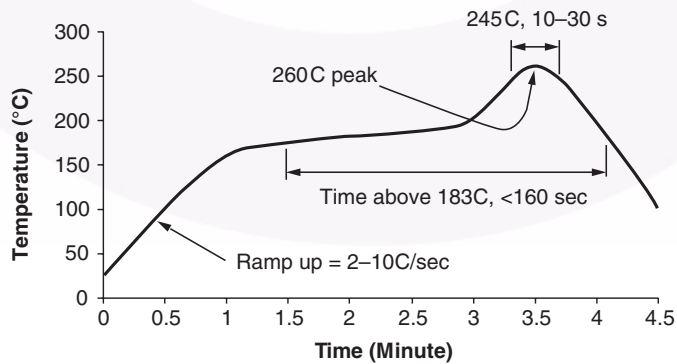
Definitions	
1	Fairchild logo
2	Device number
3	VDE mark (Note: Only appears on parts ordered with VDE option – See order entry table)
4	Two digit year code, e.g., '03'
5	Two digit work week ranging from '01' to '53'
6	Assembly package code

## Carrier Tape Specifications



Symbol	Description	Dimension in mm
W	Tape Width	16.0 ± 0.3
t	Tape Thickness	0.30 ± 0.05
P <sub>0</sub>	Sprocket Hole Pitch	4.0 ± 0.1
D <sub>0</sub>	Sprocket Hole Diameter	1.55 ± 0.05
E	Sprocket Hole Location	1.75 ± 0.10
F	Pocket Location	7.5 ± 0.1
P <sub>2</sub>		4.0 ± 0.1
P	Pocket Pitch	12.0 ± 0.1
A <sub>0</sub>	Pocket Dimensions	10.30 ± 0.20
B <sub>0</sub>		10.30 ± 0.20
K <sub>0</sub>		4.90 ± 0.20
W <sub>1</sub>	Cover Tape Width	1.6 ± 0.1
d	Cover Tape Thickness	0.1 max
	Max. Component Rotation or Tilt	10°
R	Min. Bending Radius	30

## Reflow Profile








- Peak reflow temperature: 260C (package surface temperature)
- Time of temperature higher than 183C for 160 seconds or less
- One time soldering reflow is recommended



**TRADEMARKS**

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|---|---|---|---|
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| CorePLUS™   | F-PFS™  | Power-SPM™  | the power franchise   |
| CorePOWER™  | FRFET®  | PowerTrench®  | TinyBoost™  |
| CROSSVOLT™  | Global Power Resource <sup>SM</sup>   | Programmable Active Droop™  | TinyBuck™   |
| CTL™  | Green FPS™  | QFET®   | TinyLogic®  |
| Current Transfer Logic™   | Green FPS™ e-Series™  | QS™   | TINYOPTO™   |
| EcoSPARK®   | GTO™  | Quiet Series™   | TinyPower™  |
| EfficientMax™   | IntelliMAX™   | RapidConfigure™   | TinyPWM™  |
| EZSWITCH™ *   | ISOPLANAR™  | Saving our world, 1mW at a time™  | TinyWire™   |
|  | MegaBuck™   | SmartMax™   | μSerDes™  |
|  | MICROCOUPLER™   | SMART START™  |  |
| Fairchild®  | MicroFET™   | SPM®  | UHC®  |
| Fairchild Semiconductor®  | MicroPak™   | STEALTH™  | Ultra FRFET™  |
| FACT Quiet Series™  | MillerDrive™  | SuperFET™   | UniFET™   |
| FACT®   | MotionMax™  | SuperSOT™3  | VCX™  |
| FAST®   | Motion-SPM™   | SuperSOT™6  | VisualMax™  |
| FastvCore™  | OPTOLOGIC®  | SuperSOT™8  |   |
| FlashWriter® *  | OPTOPLANAR®   | SupreMOS™   |   |
|   |  | SyncFET™  |   |
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**PRODUCT STATUS DEFINITIONS**

**Definition of Terms**

Datasheet Identification	Product Status	Definition
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Preliminary	First Production	Datasheet contains preliminary data; supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.
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